CHIP LC TRAP FILTER LQZ02HQ□□□□02□ Reference Specification

1.Scope

This reference specification applies to LQZ02HQ series, Chip LC Trap filter.

2.Part Numbering

(ex) LQ Q 0 02 Н 242 Product ID Structure Dimension Туре Electrode Packaging Category Resonant Bandwidth Features L:4mm-wide / plastic tape E:8mm-wide / plastic tape $(L \times W)$ frequency B:Bulk

*Bulk packing also available. (A product is put in the plastic bag under the taping conditions.)

3.Rating

Operating Temperature.
 Storage Temperature.
 -55°C to +125°C
 -55°C to +125°C

Customer Part Number	MURATA Part Number	Impedance Insertion Loss Characteristic (Ω Typ.)		DC Resistance	Rated Current	Self Resonant				
		at 2.40GHz	at 2.44GHz	at 2.50GHz	at 2.40GHz	at 2.44GHz	at 2.50GHz	(Ω max)	(mA)	(GHz Typ.)
	LQZ02HQ242A02L	460	600	345	15.0	15.7	13.0	0.55	200	2.44
	LQZ02HQ242A02E	460	600	345	15.0	15.7	13.0	0.55	200	2.44

^{*} Typical value is actual performance.

4. Testing Conditions

《Unless otherwise specified》 《In case of doubt》

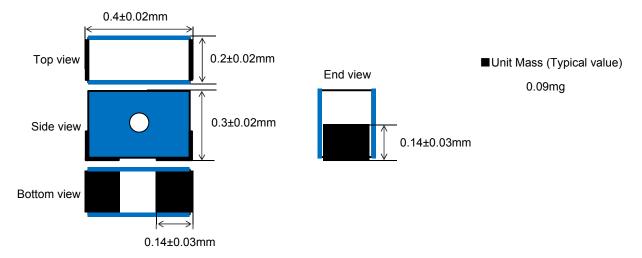
Temperature : Ordinary Temperature / 15°C to 35°C Temperature : 20°C ± 2°C

Humidity: Ordinary Humidity / 25%(RH) to 85 %(RH)

Humidity : 60%(RH) to 70 %(RH)

Atmospheric Pressure : 86kPa to 106 kPa

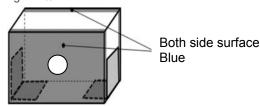
5. Appearance and Dimensions



6. Marking

Side surface identification marking :Blue

Polarity Marking :white



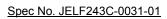


7. Electrical Performance

No.	Item	Specification	Test Method
7.1	Insertion Loss Characteristic	Insertion Loss Characteristic shall meet item 3.	Measuring Equipment: KEYSIGHT E4991B or equivalent Measuring Condition: Test signal level / about 0dBm Electrical length /0mm Weight: about 250g Measuring Fixture: KEYSIGHT 16198A Contact board: (KEYSIGHT : Guide PCA0201, 100 μ m gap between electrode:60 μ m) Measuring example> Measuring Method:See the endnote <= [electrical Performance:Measuring Method of Inductance/Q> $Z0=50\Omega$ $S21 = 20 \log \left(\frac{2Z_0}{(Zc + 2Z_0)}\right)$
7.3	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment:Digital multi meter
7.4	Self Resonant Frequency(S.R.F)	S.R.F shall meet item 3.	Measuring Equipment: KEYSIGHT N5230A or equivalent
7.5	Rated	Self temperature rise shall be	The rated current is applied.
	Current	limited to 25°C max.	

8.Mechanical Performance

No.	Item	Specification	Test Method
No. 8.1	Item Shear Test	Specification Chip coil shall not be damaged after tested as test method. DC resistance Change: within ±10%	Substrate:Glass-epoxy substrate Land 0.16 0.56 Force:1N Hold Duration:5 s±1 s
			Applied Direction: Parallel to PCB Chip coil Substrate



No.	Item	Specification	Test Method
8.2	Bending Test	Chip coil shall not be damaged after tested as test method. DC resistance Change: within ±10%	Substrate:Glass-epoxy substrate (100mm × 40mm × 0.8mm) Speed of Applying Force:1mm /s Deflection:1mm Hold Duration:30 s Pressure jig R340 F Deflection Deflection
8.3	Vibration	Appearance:No damage	Substrate: Glass-epoxy substrate Oscillation Frequency: 10Hz to 2000Hz to 10Hz for 20 min Total amplitude 1.5 mm or Acceleration amplitude 196 m/s² whichever is smaller. Testing Time:A period of 2h in each of 3 mutually perpendicular directions.
8.4	Solderability	The electrode shall be at least 90% covered with new solder coating.	Flux: Ethanol solution of rosin 25(wt)% (Immersed for 5s to 10s) Solder:Sn-3.0Ag-0.5Cu Pre-Heating:150°C±10°C / 60s to 90s Solder Temperature:240°C±5°C Immersion Time:3s±1s
8.5	Resistance to Soldering Heat	Appearance:No damage DC resistance Change: within ±10%	Flux: Ethanol solution of rosin 25(wt)% (Immersed for 5s to 10s) Solder:Sn-3.0Ag-0.5Cu Pre-Heating:150°C±10°C / 60s to 90s Solder Temperature:260°C±5°C Immersion Time:5s±1s Then measured after exposure in the room condition for 24h±2h.

9.Environmental Performance

It shall be soldered on the substrate.

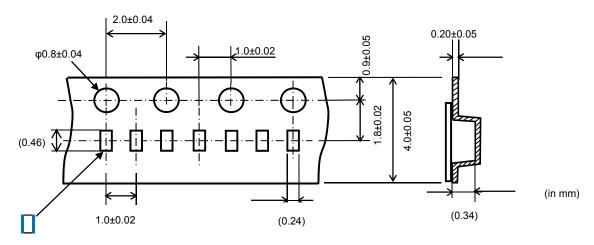
No.	Item	Specification	Test Method
9.1	Heat Resistance	Appearance:No damage	Substrate: Glass-epoxy substrate
		DC resistance Change: within ±10%	Temperature:125°C±2°C
			Time:1000h (+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.2	Cold Resistance		Substrate: Glass-epoxy substrate
			Temperature:-55°C±3°C
			Time:1000 h (+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.3	Humidity		Substrate: Glass-epoxy substrate
			Temperature:40°C±2°C
			Humidity:90%(RH) to 95%(RH)
			Time:1000 h(+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.4	Temperature		Substrate: Glass-epoxy substrate
	Cycle		1 cycle:
			1 step:-55°C±2°C / 30min±3 min
			2 step:Ordinary temp. / 10~15 min
			3 step:125°C±2°C / 30±3 min
			4 step: Ordinary temp. / 10~15 min
			Total of 10 cycles
			Then measured after exposure in the
			room condition for 24h±2h.

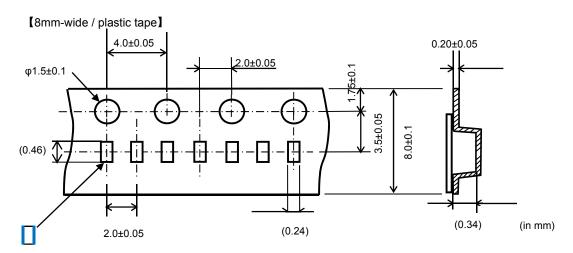


10. Specification of Packaging

10.1 Appearance and Dimensions

[4mm-wide / plastic tape]





Dimension of the Cavity is measured at the bottom side.

10.2 Specification of Taping

[4mm-wide / plastic tape]

- (1) Packing quantity (standard quantity)
 - 30,000 pcs. / reel
- (2) Packing Method

Products shall be packed in the each embossed cavity of plastic tape and sealed by cover tape.

- (3) Sprocket hole
 - The sprocket holes are to the right as the tape is pulled toward the user.
- (4) Spliced point

Plastic tape and Cover tape has no spliced point.

(5) Missing components number

Missing components number within 0.1 % of the number per reel or 1 pc. , whichever is greater, and are not continuous. The Specified quantity per reel is kept.



[8 mm-wide / plastic tape]

(1) Packing quantity (standard quantity)

15,000 pcs. / reel

(2) Packing Method

Products shall be packed in the each embossed cavity of plastic tape and sealed by cover tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Plastic tape and Cover tape has no spliced point.

(5) Missing components number

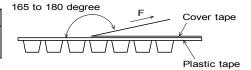
Missing components number within 0.1% of the number per reel or 1 pc., whichever is greater, and are not continuous. The Specified quantity per reel is kept.

10.3 Pull Strength

Cover tape	5N min
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10.4 Peeling off force of cover tape

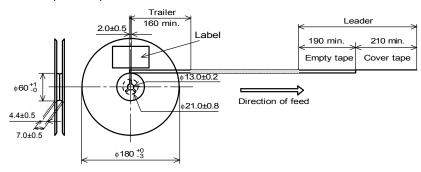
Speed of Peeling off	300mm/min		
Peeling off force	0.1N to 0.6N		
reening on loice	(minimum value is typical)		



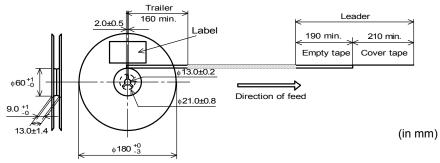
10.5 Dimensions of Leader-tape, Trailer and Reel

There shall be leader-tape (top tape and empty tape) and trailer-tape (empty tape) as follows.

[4mm-wide / plastic tape]



[8mm-wide / plastic tape]



10.6 Marking for reel

Customer part number, MURATA part number, Inspection number(*1), RoHS Marking(*2), Quantity etc · ·

*1) < Expression of Inspection No.>

□□ 0<u>000</u> <u>×××</u>

(1) Factory Code

: Year / Last digit of year (2) Date First digit

Second digit: Month / Jan. to Sep. \rightarrow 1 to 9, Oct. to Dec. \rightarrow O,N,D

Third, Fourth digit: Day

(3) Serial No.

*2) <Expression of RoHS Marking >

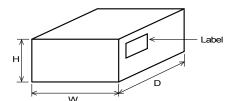
ROHS
$$-\frac{Y}{(1)}(\underline{\Delta})$$

- (1) RoHS regulation conformity parts.
- (2) MURATA classification number

10.7 Marking for Outside package (corrugated paper box)

Customer name, Purchasing order number, Customer part number, MURATA part number, RoHS Marking (*2), Quantity, etc · · ·

10.8 Specification of Outer Case



Outer Case Dimensions (mm)			Standard Reel Quantity in Outer Case (Reel)
W	D	Н	in Outer Case (Reei)
186	186	93	5(8mm-wide / plastic tape)
			10(4mm-wide / plastic tape)

* Above Outer Case size is typical. It depends on a quantity of an order.

11. / Caution

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

- (1) Aircraft equipment
- (2) Aerospace equipment (3) Undersea equipment
- Undersea equipment
- (4) Power plant control equipment (5) Medical equipment
- (6) Transportation equipment (vehicles, trains, ships, etc.)
- Traffic signal equipment
- (7) Traffic signal equipment (8) Disaster prevention / crime prevention equipment
- (9) Data-processing equipment
 (10) Applications of similar complexity and /or reliability requirements to the applications listed in the above

12. Notice

Products can only be soldered with reflow.

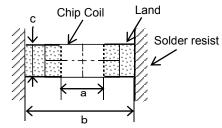
This product is designed for solder mounting.

Please consult us in advance for applying other mounting method such as conductive adhesive.

Please check the mounting condition before using.

Using mounting conditions (nozzles, equipment conditions, etc.) that are not suitable for products may lead to pick up errors, misalignment, or damage to the product.

12.1 Land pattern designing



а	0.20
b	0.56
С	0.16
	(in mm)

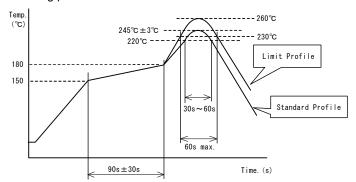


12.2 Flux, Solder

- · Use rosin-based flux.
- Don't use highly acidic flux with halide content exceeding 0.2(wt)% (chlorine conversion value). Don't use water-soluble flux.
- Use Sn-3.0Ag-0.5Cu solder.
- Standard thickness of solder paste : 50 μm ~65 μm.

12.3 Reflow soldering conditions

- Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 150°C max. Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max. Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of products quality.
- Standard soldering profile and the limit soldering profile is as follows.
 The excessive limit soldering conditions may cause leaching of the electrode and / or resulting in the deterioration of product quality.
- · Reflow soldering profile



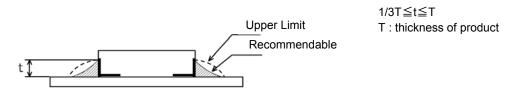
	Standard Profile	Limit Profile	
Pre-heating	150°C~180°	,90s±30s	
Heating	above 220°C, 30s∼60s	above 230°C, 60s max.	
Peak temperature	245°C±3°C	260°C,10s	
Cycle of reflow	2 times	2 times	

12.4 Reworking with soldering iron

Reworking with soldering iron is disapproved.

12.5 Solder Volume

· Solder shall be used not to be exceeded the upper limits as shown below.



Accordingly increasing the solder volume, the mechanical stress to Chip is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance and become easy to tilt.

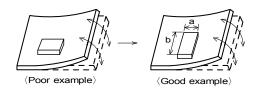


12.6 Attention regarding P.C.B. bending

The following shall be considered when designing and laying out P.C.B.'s.

(1) P.C.B. shall be designed so that products are not subject to the mechanical stress due to warping the board.

[Products direction]



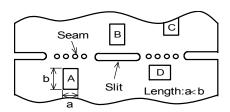
Products shall be located in the sideways direction (Length:a < b) to the mechanical stress.

(2) Components location on P.C.B. separation.

It is effective to implement the following measures, to reduce stress in separating the board.

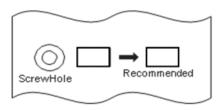
It is best to implement all of the following three measures; however, implement as many measures as possible to reduce stress.

Contents of Measures	Stress Level
(1) Turn the mounting direction of the component parallel to the board separation surface.	A > D*1
(2) Add slits in the board separation part.	A > B
(3) Keep the mounting position of the component away from the board separation surface.	A > C



- *1 A > D is valid when stress is added vertically to the perforation as with Hand Separation. If a Cutting Disc is used, stress will be diagonal to the PCB, therefore A > D is invalid.
- (3) Mounting Components Near Screw Holes

When a component is mounted near a screw hole, it may be affected by the board deflection that occurs during the tightening of the screw. Mount the capacitor in a position as far away from the screw holes as possible.



12.7 Cleaning Conditions

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max.(40°C max for IPA)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.

Power: 20 W / I max. Frequency: 28kHz to 40kHz Time: 5 min max.

- (3) Cleaner
 - 1. Alcohol type cleaner Isopropyl alcohol (IPA)
 - 2. Aqueous agent PINE ALPHA ST-100S





- (4) There shall be no residual flux and residual cleaner after cleaning. In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning Please contact us.

12.8 Resin coating

When products are coated with resin, please contact us in advance.

12.9 Handling of a substrate

(1)There is a possibility of chip cracking caused by PCB expansion/contraction with heat, because stress on a chip is different depending on PCB material and structure.

When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction.

The chip is assumed to be mounted on the PCB of glass-epoxy material, and we don't test with other PCB material which has different thermal expansion coefficient from Glass-epoxy.

When other PCB materials are considered, please be sure to evaluate by yourself.

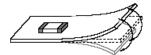
(2)After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

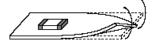
Excessive mechanical stress may cause cracking in the product.

In case of the mounting on flexible PCB, there is a possibility of chip cracking caused by mechanical stress even from small bending or twisting.

When the flexible PCB is considered, please be sure to evaluate by yourself.

Bending Twisting





12.10 Storage and Handing Requirements

(1) Storage period

Use the products within 12 months after deliverd.

Solderability should be checked if this period is exceeded.

(2) Storage conditions

• Products should be stored in the warehouse on the following conditions.

Temperature : -10°C ~ 40°C

Humidity : 15% to 85% relative humidity No rapid change on temperature and humidity.

- Products should not be stored on bulk packaging condition to prevent the chipping of the core and the breaking of winding wire caused by the collision between the products.
- Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.
- Products should be stored in the warehouse without heat shock, vibration, direct sunlight and so on.

(3) Handling Condition

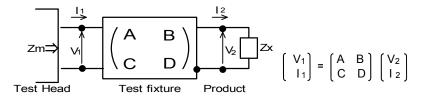
Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

13./\!\ Note

- (1)Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2)You are requested not to use our product deviating from the reference specifications.
- (3)The contents of this reference specification are subject to change without advance notice. Please approve our product specifications or transact the approval sheet for product specifications before ordering.

-<Electrical Performance:Measuring Method of Inductance/Q>-

(1) Residual elements and stray elements of test fixture can be described by F-parameter shown in following.



(2) The impedance of chip coil Zx and measured value Zm can be described by input/output current/voltage.

$$Zm = \frac{V_1}{I_1} \qquad Zx = \frac{V_2}{I_2}$$

(3) Thus, the relation between Zx and Zm is following;

$$Zx = \alpha \frac{Zm - \beta}{1 - Zm \Gamma}$$
 where, $\alpha = D / A = 1$
 $\beta = B / D = Zsm - (1 - Yom Zsm)Zss$
 $\Gamma = C / A = Yom$

Zsm:measured impedance of short chip Zss:residual impedance of short chip (0.19nH) Yom:measured admittance when opening the fixture

(4) Lx and Qx shall be calculated with the following equation.

$$Lx = \frac{Im(Zx)}{2\pi f}, \quad Qx = \frac{Im(Zx)}{Re(Zx)}$$

$$Lx : Inductance of chip coil Qx: Q of chip coil f : Measuring frequency$$